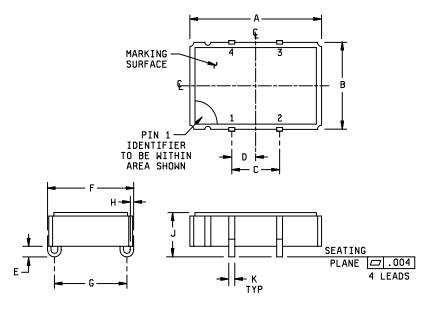
INCH-POUND
MIL-PRF-55310/30D
15 October 2008
SUPERSEDING
MIL-PRF-55310/30C
09 June 2008

PERFORMANCE SPECIFICATION SHEET

OSCILLATOR, CRYSTAL CONTROLLED, TYPE 1 (CRYSTAL OSCILLATOR (XO)), 450 kHz THROUGH 100 MHz, HERMETIC SEAL, LOW VOLTAGE CMOS

This specification is approved for use by all Departments and Agencies of the Department of Defense.

The requirements for acquiring the product described herein shall consist of this specification sheet and MIL-PRF-55310.



Pin number	Function
1	Enable/Disable
2	GND
3	Output
4	V_{DD}

Ltr	Incl	hes	mm		
	Min	Max	Min	Max	
Α	N/A	.560	N/A	14.22	
В	N/A	.360	N/A	9.14	
С	.195	.205	4.95	5.21	
D	.086	.114	2.18	2.90	
Ш	.025	.055	.635	1.40	
F	N/A	.378	N/A	9.60	
G	.292	.308	7.42	7.82	
Н	.007	.009	.178	.229	
J	N/A	.188	N/A	4.78	
K	.015	.021	.381	.533	

NOTES:

- 1. Dimensions are in inches.
- 2. Metric equivalents are given for general information only.
- 3. Unless otherwise specified, tolerances are ±.005 (0.13 mm) for three place decimals and ±.02 (0.5 mm) for two place decimals.

FIGURE 1. <u>Dimensions and configuration</u>.

AMSC N/A FSC 5955

REQUIREMENTS:

Interface and physical dimensions: See figure 1.

Mounting: See figure 1.

Pads: See figure 1.

Seal: Hermetic in accordance with MIL-PRF-55310, maximum leakage rate 5 x 10⁻⁸ atm cc/s.

Weight: 3 grams, maximum.

Oscillator: Class 2 or any class 1 or class 3 oscillator meeting all class 2 requirements and verification tests

specified herein and in MIL-PRF-55310.

Calibration: Manufacturer calibrated.

Screening: In accordance with MIL-PRF-55310, product level B or S, as applicable.

Temperature:

Operating: See table I.

Storage: -62°C to +125°C.

Load test circuit: See figure 2.

Output waveform: Symmetrical square wave, 3.3 volt CMOS logic compatible (see figure 3).

Output logic voltage levels at designated CMOS (see figure 3):

Logic 1: 90 percent of V_{DD}, minimum.

Logic 0: 10 percent of V_{DD} , maximum.

Rise and fall times: (See table I) Measurements shall be taken at the 10 percent and 90 percent peak-to-peak

output voltage levels, with peak-to-peak output defined as level 1-level 0 (see figure 3).

Duty cycle: See table I and figure 3.

Supply voltage: +3.3 V dc ±10 percent.

Input current: At designated supply voltage (see table I).

Enable/disable:

Output disabled (high impedance): Pin 1 input \leq 0.3 V dc.

Output active: Pin 1 input \geq 2.0 V dc or open.

Output frequency: Frequency as designated at time of acquisition (see table I).

Initial accuracy at reference temperature (up to 30 days after shipment): See table I.

TABLE I. Dash numbers and operating characteristics.

Dash	Output	Input	Pulse characteristics		Initial		Frequency-temperature		
number	frequency	current			accuracy	tolerance (ppm)			
	range	(max) <u>1</u> /	Rise and	Duty cycle	at +23°C	-55°C	-55°C	-20°C	
			fall times	min-max	±1°C	to	to	to	
			(max) <u>2</u> /	<u>2</u> /		+125°C	+105°C	+70°C	
						Α	В	С	
01	450 kHz to	8 mA	10 ns	45% to 55%	±15 ppm	±50	±40	±25	
	14.999 MHz					ppm	ppm	ppm	
04	450 kHz to	8 mA	10 ns	45% to 55%	±25 ppm	±100	±80	±50	
	14.999 MHz					ppm	ppm	ppm	
11	15.000 MHz to	10 mA	10 ns	45% to 55%	±15 ppm	±50	±40	±25	
	29.999 MHz					ppm	ppm	ppm	
14	15.000 MHz to	10 mA	10 ns	45% to 55%	±25 ppm	±100	±80	±50	
	29.999 MHz					ppm	ppm	ppm	
21	30.000 MHz to	20 mA	5 ns	40% to 60%	±15 ppm	±50	±40	±25	
	59.999 MHz					ppm	ppm	ppm	
24	30.000 MHz to	20 mA	5 ns	40% to 60%	±25 ppm	±100	±80	±50	
	59.999 MHz					ppm	ppm	ppm	
31	60.000 MHz to	30 mA	3 ns	40% to 60%	±15 ppm	±50	±40	±25	
	85.000 MHz					ppm	ppm	ppm	
34	60.000 MHz to	30 mA	3 ns	40% to 60%	±25 ppm	±100	±80	±50	
	85.000 MHz				- 11	ppm	ppm	ppm	
41	85.000 MHz to	30 mA	3 ns	40% to 60%	±15 ppm	±50	±40	±25	
	100.00 MHz					ppm	ppm	ppm	
44	85.000 MHz to	30 mA	3 ns	40% to 60%	±25 ppm	±100	±80	±50	
	100.00 MHz			2,2 12 23,0	c pp	ppm	ppm	ppm	

^{1/} Maximum input current for no load condition.

Frequency-temperature tolerance (one-half temperature cycle, referenced to frequency measured at $+23^{\circ}$ C $\pm 1^{\circ}$ C, immediately prior to starting of the test): See table I. Measurements taken at ten equally spaced increments over the specified operating temperature range. 1/

Frequency-voltage tolerance: ± 4 ppm maximum for a ± 10 percent change in supply voltage. Measurements taken at reference temperature and operating temperature range end points.

Frequency aging: Measurements shall be taken at $+70^{\circ}$ C $\pm 0.2^{\circ}$ C at intervals of not more than every 72 hours for 30 days minimum.

±10 ppm per year, maximum

±1.5 ppm per 30 days.

±3 ppm per 90 days.

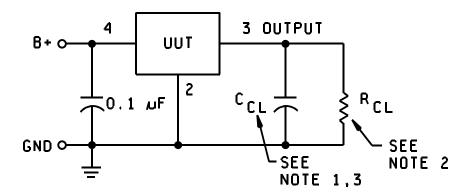
Terminal strength: Method 211 of MIL-STD-202, test condition A.

Applied force: 8 ounces each terminal.

Frequency-environmental tolerance: Not applicable.

^{2/} See figure 3.

^{1/} For the purpose of transitioning this device to MIL-PRF-55310, 'Frequency stability versus temperature' has been renamed 'Frequency-temperature tolerance'. The verification requirements of 'initial frequency-temperature accuracy (one-half temperature cycle)' shall apply except that frequency measurements shall be referenced to the frequency measured at $\pm 23^{\circ}$ C $\pm 1^{\circ}$ C (f_{ref}) instead of to the nominal frequency (f_{nom}).



NOTES:

- 1. For C_{CL} = 15 pF ± 5 percent.
- 2. For R_{CL} = 10 k Ω ±5 percent. 3. C_{CL} includes scope capacitance.

FIGURE 2. Load test circuit.

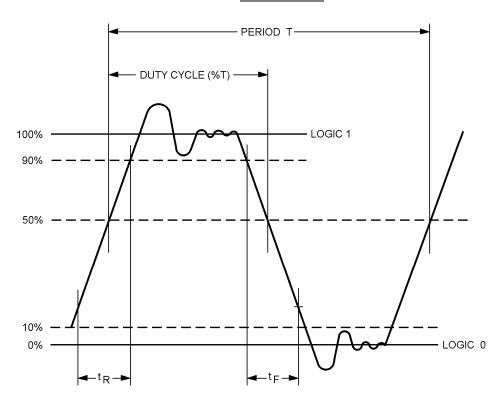


FIGURE 3. Waveform

Vibration, sinusoidal: In accordance with MIL-PRF-55310 and method 204 of MIL-STD-202.

Nonoperating: Test condition D.

Operating: Not required.

Ambient pressure:

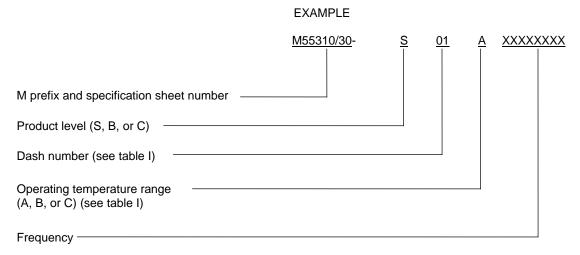
Nonoperating: In accordance with MIL-PRF-55310.

Operating: Method 105 of MIL-STD-202, test condition C.

Exposure time: 5 minutes.

Reflow soldering: Reflow soldering of the unit at +230°C ±10°C for 15 seconds shall not degrade the performance.

Part or Identifying Number (PIN): Consists of "M" prefix followed by specification sheet number, a dash and coded alphas, and numeric number. See example:



Reference documents. In addition to MIL-PRF-55310, this document references the following:

MIL-STD-202

The margins of this specification are marked with vertical lines to indicate where changes from the previous issue were made. This was done as a convenience only and the Government assumes no liability whatsoever for any inaccuracies in these notations. Bidders and contractors are cautioned to evaluate the requirements of this document based on the entire content irrespective of the marginal notations and relationship to the last previous issue.

Custodians:

Army - CR Navy - EC Air Force - 99 DLA - CC Preparing activity: Army - CR

Agent: DLA - CC

(Project 5955-2008-009)

Review activities:

Army - AR, MI, SM Navy - AS, CG, MC Air Force - 19, 84 NASA - NA

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